

**Search Notes**

Application/Control No.

10/553,724

Examiner

KEVIN R. KRUEER

Applicant(s)/Patent under  
Reexamination

FUJII ET AL.

Art Unit

1794

**SEARCHED**

Class	Subclass	Date	Examiner
428	516,347	3/30/2008	KK
update	above	4/5/2009	KK
update	above	12/2/2009	KK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search	3/30/2008	KK
EAST search	3/30/2008	KK